

<b>Notice of References Cited</b>	Application/Control No. 10/602,041	Applicant(s)/Patent Under Reexamination CHONO ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,798,166	01-1989	Hirooka et al.	118/719
	B	US-4,803,947	02-1989	Ueki et al.	118/719
	C	US-5,281,295	01-1994	Maeda et al.	156/345.29
	D	US-5,632,868	05-1997	Harada et al.	204/176
	E	US-5,904,170	05-1999	Harvey et al.	137/9
	F	US-5,928,428	07-1999	Horie, Yasuhiko	118/724
	G	US-6,019,848	02-2000	Frankel et al.	118/715
	H	US-6,065,489	05-2000	Matsuwaka, Atsuji	137/341
	I	US-6,106,659	08-2000	Spence et al.	156/345.43
	J	US-6,764,967 B2	07-2004	Pai et al.	438/787
	K	US-6,833,322 B2	12-2004	Anderson et al.	438/680
	L	US-6,869,499 B2	03-2005	Toshima et al.	156/345.29
	M	US-2002/0045008 A1	04-2002	Toshima et al.	427/248.1

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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#### NON-PATENT DOCUMENTS

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0133854 A1	07-2003	Tabata et al.	422/186.07
	B	US-2003/0170949 A1	09-2003	Chouno et al.	438/200
	C	US-2004/0002224 A1	01-2004	Chono et al.	438/714
	D	US-2004/0063319 A1	04-2004	Toshima et al.	438/689
	E	US-2004/0069226 A1	04-2004	Yoshida et al.	118/715
	F	US-2004/0101633 A1	05-2004	Zheng et al.	427/551
	G	US-2005/0056306 A1	03-2005	Jeong et al.	134/094.1
	H	US-2005/0087133 A1	04-2005	Shindo et al.	118/715
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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